

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/584,503	VAN DER TUIJN ET AL.	
		Examiner	Art Unit	Page 1 of 1
		ERIN FILE	2611	

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,310,751 A	03-1967	ATZENBECK CHARLES R	327/166
*	B	US-6,246,723 B1	06-2001	Bliss et al.	375/265
*	C	US-6,272,102 B1	08-2001	Kahlman, Josephus A. H. M.	369/124.01
*	D	US-2002/0024846 A1	02-2002	Kawahara et al.	365/185.24
*	E	US-2005/0066083 A1	03-2005	Chan et al.	710/052
*	F	US-7,128,270 B2	10-2006	Silverbrook et al.	235/472.01
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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